

03500.103123

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)	
	:	Examiner: B. Gordon
MANABU KOMATSU ET AL.	)	
	:	Group Art Unit: 1743
Application No.: 10/553,660	)	
	:	Confirmation No. 4672
Int'l Appln. No. PCT/JP2004/019716	)	
	:	
Filed: December 22, 2004	)	
	:	
For: TEST SPECIMEN AND	)	
PRODUCTION THEREOF	:	December 13, 2006

**Mail Stop PCT**  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

SECOND INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the attached Form PTO-1449. Since the U.S. Patent and Trademark Office waived the requirement under 37 C.F.R. § 1.98 (a)(2)(i) for submitting a copy of each cited U.S. patent and each U.S. patent application publication for all U.S. national patent applications and for all international applications that have entered the national stage under 35 U.S.C. § 371, no copies of such documents are provided. Copies of the other documents are submitted herewith.

The concise explanation of relevance for the non-English documents may be found, *inter alia*, in the English language abstracts attached thereto and/or in the specification where they are cited. Also, the concise explanation of relevance for JP 2000-251665 and JP 11-187900 may be found, respectively, in related U.S. Patent Nos. 6,579,139 B1 and 6,476,215 B1.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the attached Form PTO-1449 be returned indicating that such information has been considered.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

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FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>03500.103123</b>		APPLICATION NO. <b>10/553,660</b>	
				APPLICANT <b>Manabu Komatsu et al.</b>			
				FILING DATE <b>December 22, 2004</b>		GROUP <b>1743</b>	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,365,563	11/15/94	Kira et al.	378	48	
		6,579,139 B1	06/17/03	Mishima et al.	445	24	
		6,476,215 B1	11/05/02	Okamoto et al.	536	25.3	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	JP	2000-251665	09/14/00	Japan			Abstract
	JP	11-187900	07/13/99	Japan			Abstract
	JP	4-361055	12/14/92	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
		<b>Paolo Lazzeri et al., "Use of Spin-Coated TXRF Reference Samples for ToF-SIMS Metal Contaminant Quantification on Silicon Wafers," 29 Surf. Interface Anal. 798-803 (2000).</b>					
EXAMINER				DATE CONSIDERED			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.